

**Search Notes**

Application/Control No.

10/777,142

Examiner

Leith A. Al-Nazer

Applicant(s)/Patent under  
Reexamination

IDE ET AL.

Art Unit

2821

**SEARCHED**

| Class | Subclass | Date      | Examiner |
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| 349   | 149-152  | 7/11/2005 | LA       |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE      | EXMR |
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| EAST text search (see "Examiner Search Notes") | 7/11/2005 | LA   |
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